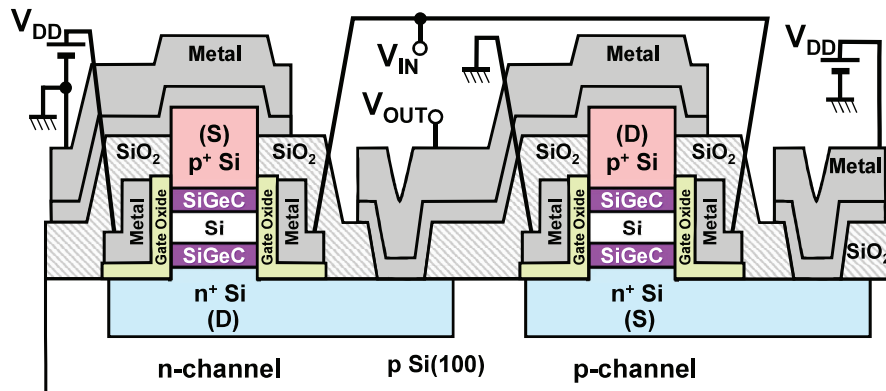


Issues for improved current drivability

- Heavy doping/diffusion control
- High-performance gate stack
- Reduction of effective bandgap by heteroepitaxy
- Si/strained Si-Ge alloy, Ge/strained Si, Ge/Ge-Sn alloy, ...

Targeted Structure

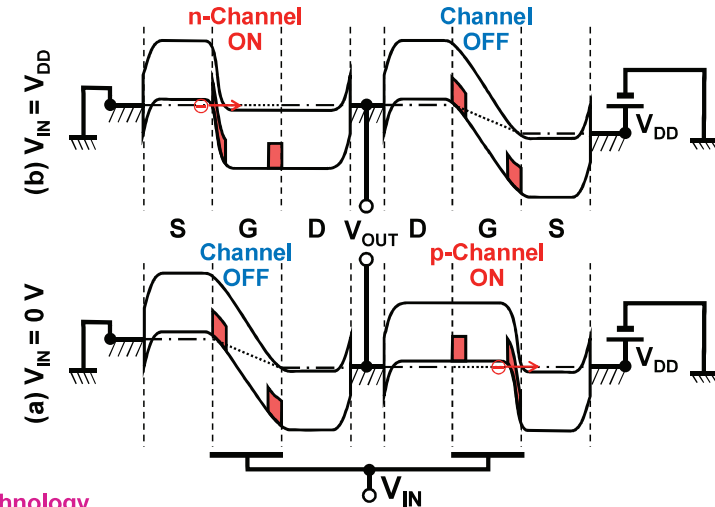
- Vertical-type tunnel transistor with double sidewall gates
- Utilizing epitaxial growth of **strained Si-C/Si-Ge-C alloy** and **Si** with abrupt heterointerfaces for effective band discontinuity



V_{Th} control by back-gate bias + Thinning channel fin (~10 nm)

→ Volume accumulation in n/p-channel for improved current drivability

- Complementary switching by V_{Th} control with double gates
- Local reduction of effective bandgap by **strained Si-C or Si-Ge-C alloy**

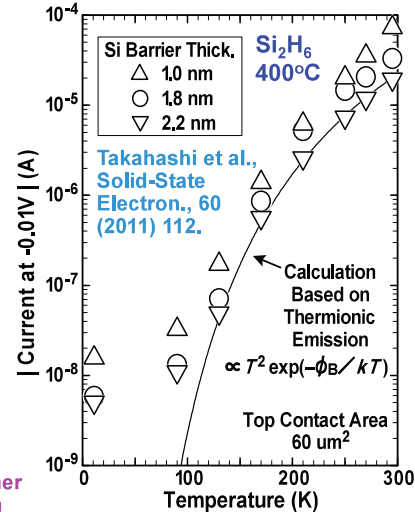
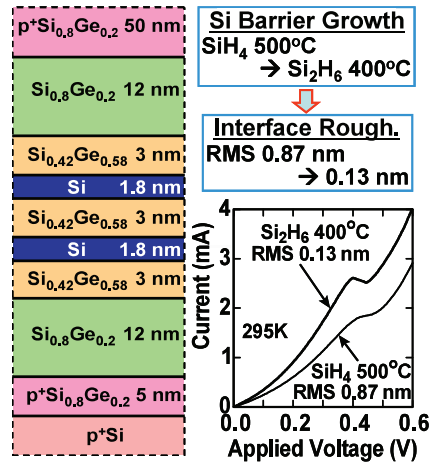


Key Technology

Low-Temperature Epitaxial Growth/In-Situ Heavy Doping (Abrupt Interfaces)

Quantum Heterointegration Process of Highly Strained Group IV Semiconductors (1)

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For Si-Ge resonant tunneling devices with higher performance, formation of heterostructure with nanometer-order thick films and control of atomic-order flatness are necessary. Moreover, exploring of higher barrier height materials for tunnel barriers is important.

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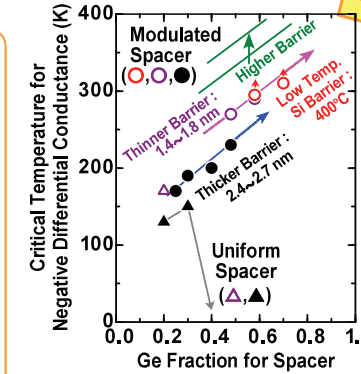
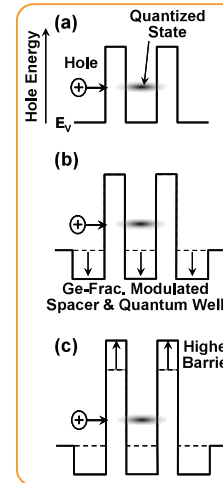
Quantum Heterointegration Process of Highly Strained Group IV Semiconductors (2)

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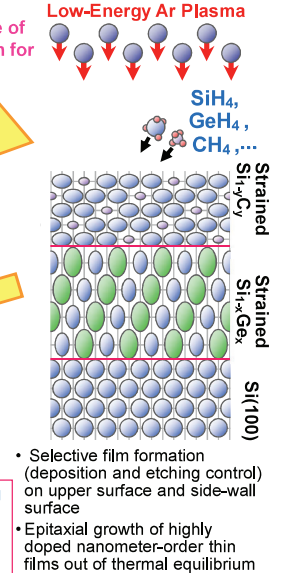
- Surface reaction control of ultraclean reactant gases under low-damage and low-energy plasma without substrate heating
- Adsorption and reaction control by utilizing reactant gas activation (modification)
- Epitaxial growth of highly strained nanometer-order thin films out of thermal equilibrium

Expanding range of plasma condition for epitaxial growth

Low-Energy Ar Plasma



- Improvement of room-temp. resonant tunneling characteristics by utilizing highly strained nanometer-order thin films
- Establishment of heterointegration process of quantum-effect nanodevices



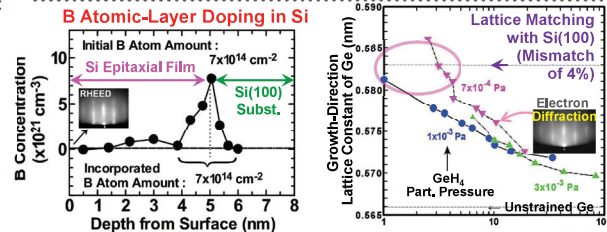
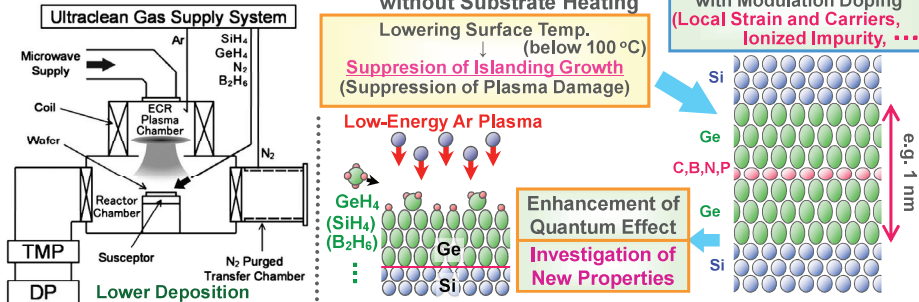
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Plasma CVD Processing for Group-IV Semiconductor Quantum Heterostructure

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Key Eng. Mat., 470 (2011) 98

Low-Energy (<10 eV) Plasma Irradiation for Epitaxial Growth without Substrate Heating

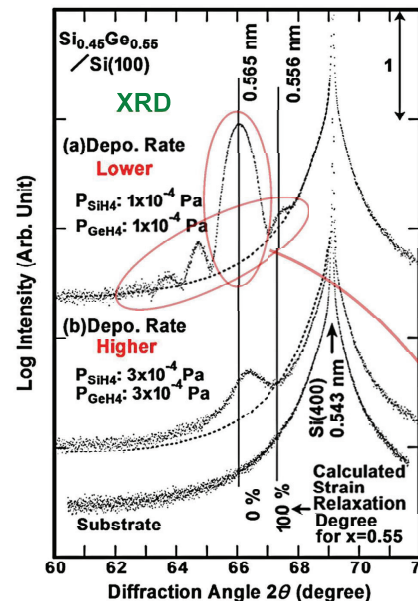


Epitaxial Growth of Highly Strained Ge

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Strained Si-Ge Alloy Epitaxy on Si(100) w/o Subst. Heating

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